FIG. 1

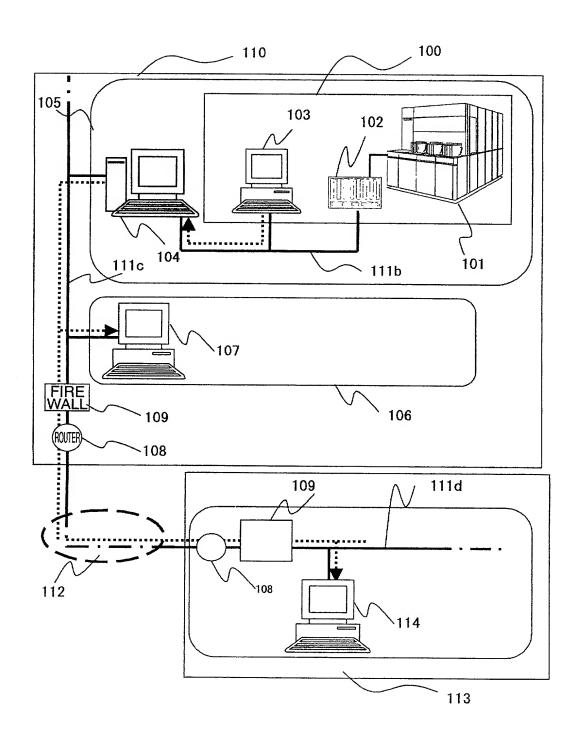


FIG. 2

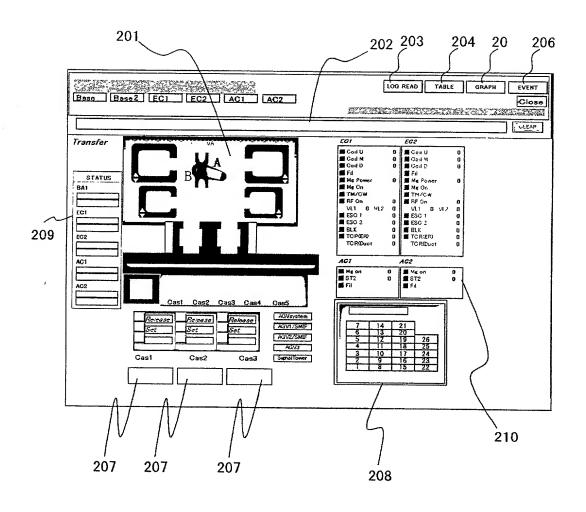
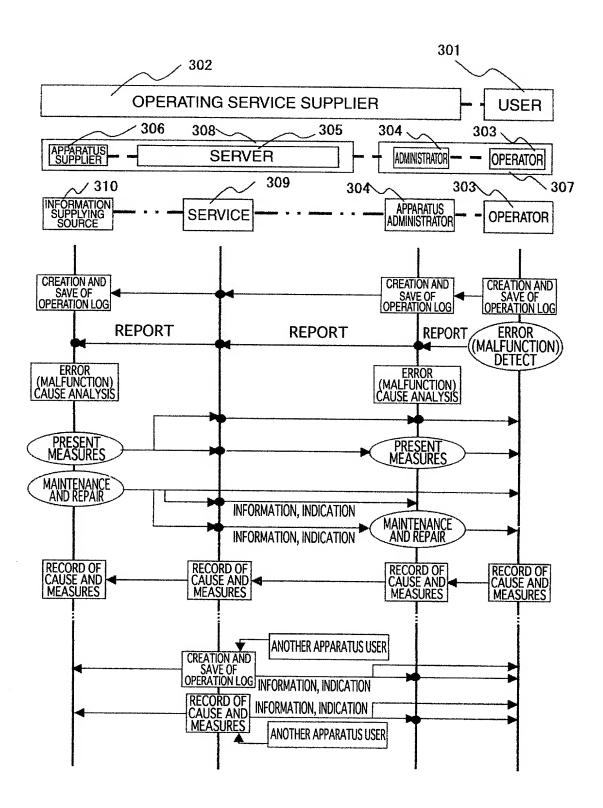
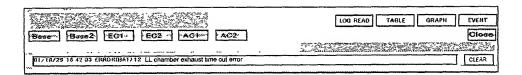


FIG. 3



## FIG. 4A



## FIG. 4B

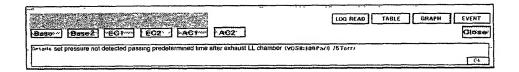
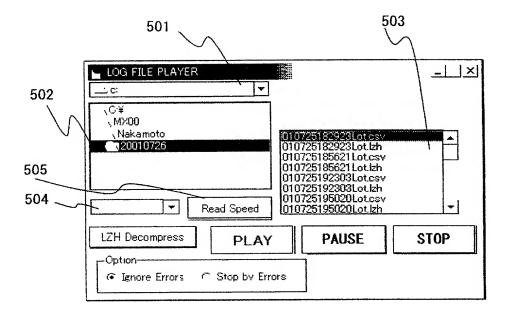


FIG. 5



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FIG. 6

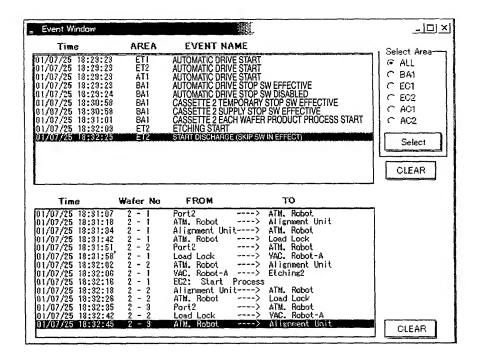


FIG. 7

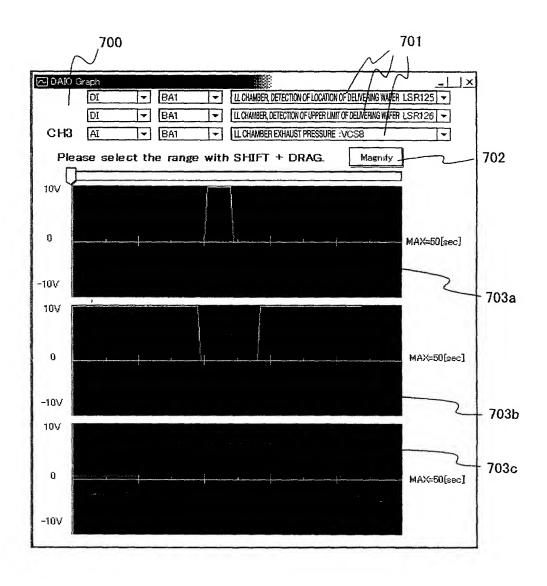
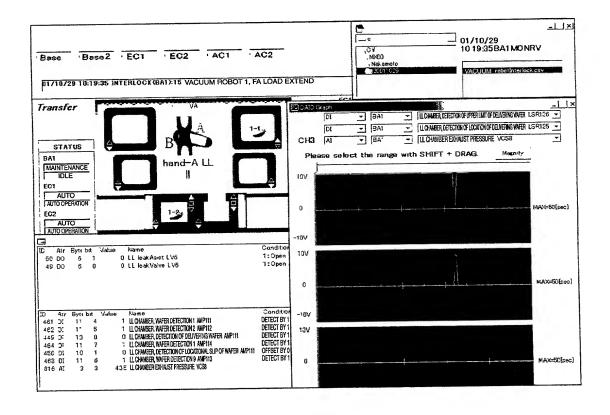


FIG. 8

IU	TAB	LE				
ID	Atr	Byte bit	Value	Name	Condition	T
- 21	DQ	3 (	ò	O LP1 READY		
34	DO	4		0 LP1 HO-AVBL SMIF1 Ready to UL		-
32	DO	3	7	0 LP1 ES		
35	DO.		2	0 LPT LREQ SMIFT Port Lock		1
33	DO	4	)	0 LP1 UREQ 3MIF1 Load/Unload		
						Ţ
ID	Atr	Byte bit	Value	Name	Condition	-
415	DI	5 (	5	0 LP1 TR REQ		
414	DI		5	0 LP1 CS2		
409	DI	5 (	3	O LP1 BUSY		<u> </u>
416	DI	5	7	0 LP1 CONT		- 1
410	DI	5 1		0 LP1 COMPT		
413	DI	5 4	1	0 LP1 CS1		- 1
412	DI	5 3	}	0 LP1 CS0		1
411	DI	5 .	2	0 LP1 VALID		<u> </u>

S ( ) ~

FIG. 9



1.

FIG. 10

LIST OF OCCURRENCE ERROR CAUSES								
ERROR: TIMEOUT ERROR OF DELIVERING LOCATION OF LL CHAMBER								
LARGER								
POSSIBILITY	DELIVERING LOCATION SENSOR OF LL CHAMBER	Î						
	LOWER LIMIT LOCATION SENSOR OF LL CHAMBER							
	UPPER LIMIT LOCATION SENSOR OF LL CHAMBER							
	VACUUM DETECTION SENSOR OF LL CHAMBER							
	VACUUM GAUGE OF LL CHAMBER							
	- 11111 - 11111 - 11111 - 11111 - 11111							